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Accession number: 13054086

Title:THz Imaging Using a Quantum-well Photodetector with Background Limited Performance Authors:Zhou Tao (1); Zhang Rong (1); Guo Xu-Guang (1); Tan Zhi-Yong (1); Cao Jun-Cheng (1) Author affiliation:(1) Key Lab. of Terahertz Solid-State Technol., Shanghai Inst. of Microsyst. & Inf. Technol, Shanghai, China

Source title: Chinese Physics Letters

Abbreviated source title: Chin. Phys. Lett. (China)

Volume:29 Issue:10

Publication date:Oct. 2012

Pages:104202 (3 pp.) Language:English ISSN:0256-307X CODEN:CPLEEU

Document type:Journal article (JA)

Publisher: Chinese Physical Society

Country of publication: China

Material Identity Number: CY92-2012-010

Abstract:Terahertz (THz) quantum well photodetectors (QWPs) are an extension of quantum well infrared photodetectors in the THz region. We construct an imaging system based on a THz QWP with a narrow response range from 3 THz to 6 THz. The peak responsivity of the THz QWP having background-limited performance is about 0.5 A/W, and the corresponding detectivity reaches 10¹¹ cm·Hz^{1/2}/W at temperature of 4.2 K. We obtain the images of a concealed object by the imaging system and prove that THz QWPs have the potential for imaging applications.

Number of references:18

Inspec controlled terms:infrared detectors - photodetectors - quantum wells - terahertz wave imaging

 $\label{tem:controlled} Uncontrolled terms: terahertz \ quantum \ well \ photodetectors - THz \ imaging - infrared photodetectors - background-limited performance - concealed object - frequency 3 THz to 6 THz - temperature 4.2 K$

Inspec classification codes:A0762 Detection of radiation (bolometers, photoelectric cells, i.r. and submillimetre waves detection) - A0720 Thermal instruments and techniques - B7230C Photodetectors - B7310N Microwave measurement techniques

Numerical data indexing:frequency 3.0E+12 6.0E+12 Hz;temperature 4.2E+00 K

Treatment: Practical (PRA); Theoretical or Mathematical (THR)

Discipline:Physics (A); Electrical/Electronic engineering (B)

DOI:10.1088/0256-307X/29/10/104202

Database:Inspec

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